| Issue Classification | Application/Control No. | Applicant(s)/Patent under Reexamination GUPTA ET AL. |
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| | Examiner Choi, Frank I | Art Unit |
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| \mathcal{F} lanh \mathcal{G} (Assistant Examiner) | 10/20/2006 (Date) | 9007 | | all and the | | Total Claims Allowed: | Allowed: |
| (Legal Instruments Examiner) | 10-30.06 (Date) | | SHEEVIIP SUPERVISORY (Primary Examiner) | SHEENI PADMANASHAN SUPERVISORY PATENT EXAMINER niner) (Date) / O | 135/25 | O.G. Print Claim(s) 1 | O.G. Print None |
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